

Notice of References Cited	Application/Control No. 10/692,347		Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner Derek L. Dupuis		Art Unit 2883	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,790,615	12-1988	Seki et al.	385/129
*	B	US-2002/0048431 A1	04-2002	Kimura, Naoki	385/47
*	C	US-6,480,647 B1	11-2002	Kitamura, Naoki	385/24
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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